Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/540,731	TAUNIER ET AL.		
Examiner	Art Unit		
 Edna Wong	1753		

	SEARCHED						
Class	Subclass	Date	Examiner				
205	239	8/23/2006	EW				
205	242	8/23/2006	EW				
205	247.	8/23/2006	EW				
205	251	8/23/2006	EW				
205	101	8/23/2006	EW				
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
Inventor Search		8/23/2006	EW
EAST		8/23/2006	EW
STN		8/23/2006	EW
Search Updated		1/8/2007	EW